## Application/Control No. Applicant(s)/Patent Under Reexamination 10/627,834 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 PHUC T DANG 2818 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,748,532	05-1998	Tanaka et al.	365/185.18
	В	US-			
	C	US-			
	D	US-			
	Е	US-			
	F	US-			
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	1	US-			
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	К	US-			
	L	US-			
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## **NON-PATENT DOCUMENTS**

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